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Statistical Learning Theory

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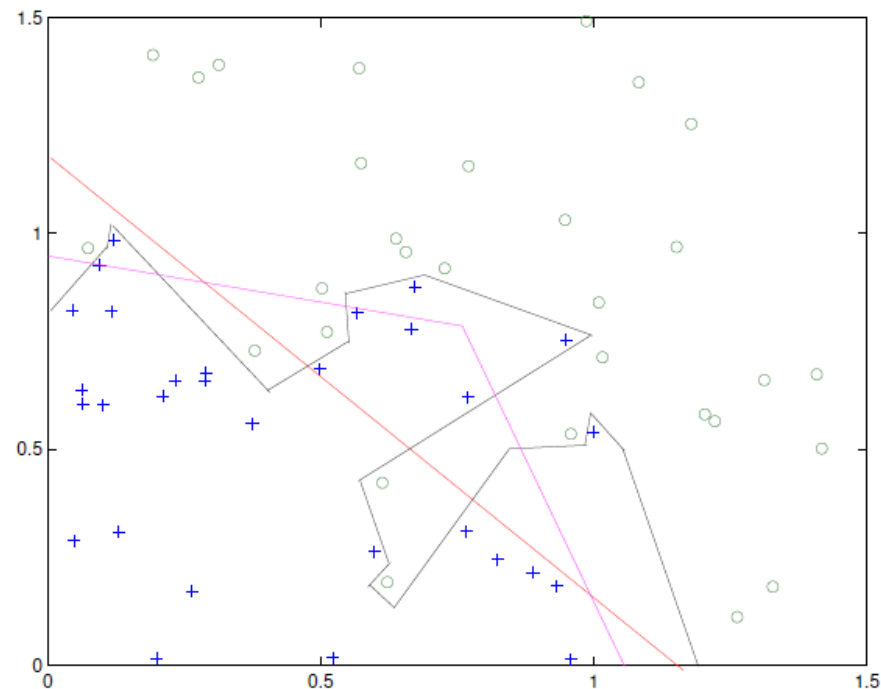
Supervised learning

◆ The basic framework:

- Data consists of pairs (instance, label)
- Label is +1 or -1
- Algorithm construct a function (instance \rightarrow label)
- Goal: make few mistakes on future unseen instances

Approximation/Interpolation

- ◆ It is always possible to build a function that fits exactly the data



- ◆ But is it reasonable?

Occam's Razor

- ◆ **Idea:** look for regularities in the observed phenomenon;
these can be generalized from the observed past to the future
 - Choose the simplest consistent model
- ◆ How to measure simplicity?
 - Number of parameters
 - Description length
 - ...

No Free Lunch

◆ No free lunch theorem:

- If there is no assumption on how the **past** is related to the **future**, prediction is **impossible**
- If there is no **restriction** on the possible phenomena, generalization is **impossible**

◆ We need to make assumptions

◆ Simplicity is not absolute

◆ Data will never replace knowledge

◆ Generalization = data + knowledge

Assumptions

◆ Two types of assumptions

- Future observations related to past ones
 - Stationarity of the phenomenon
- Constraints on the phenomenon
 - Notion of simplicity

Goals of SLT

How can we make predictions from the past?

What are the assumptions?

- ◆ Give a formal definition of learning, generalization, overfitting
- ◆ Characterize the performance of learning algorithms
- ◆ Design better algorithms

Probabilistic Model

- ◆ Relationship between past and future observations
 - Sampled independently from the same distribution
- ◆ **Independence:** each new observation yields maximum information
- ◆ **Identical distribution:** the observations give information about the underlying distribution

Probabilistic Model

- ◆ We consider an **input space** \mathcal{X} and **output space** \mathcal{Y}
 - For classification, we have $\mathcal{Y} = \{+1, -1\}$
- ◆ **Assumption**: the pairs $(X, Y) \in \mathcal{X} \times \mathcal{Y}$ are distributed according to P (unknown)
- ◆ **Data**: we observe a sequence of n i.i.d. pairs (X_i, Y_i) sampled from P
- ◆ **Goal**: construct a function $g : \mathcal{X} \rightarrow \mathcal{Y}$ which predicts Y from X

Probabilistic Model

◆ Criterion to choose our function:

- Low probability of error

$$P(g(X) \neq Y)$$

◆ **Risk:**

$$R(g) = P(g(X) \neq Y) = \mathbb{E}[1_{[g(X) \neq Y]}]$$

- P is unknown so that we cannot directly measure the risk
- Can only measure the agreement on the data

◆ **Empirical Risk:**

$$R_n(g) = \frac{1}{n} \sum_{i=1}^n 1_{[g(X_i) \neq Y_i]}$$

Target Function

◆ P can be decomposed as $P_X \times P(Y|X)$

◆ Regression function:

$$\eta(x) = \mathbb{E}[Y|X = x] = 2\mathbb{P}[Y = 1|X = x] - 1$$

◆ Target function:

$$t(x) = \text{sgn } \eta(x)$$

◆ In the deterministic case $Y = t(X)$ ($\mathbb{P}[Y = 1|X] \in \{0, 1\}$)

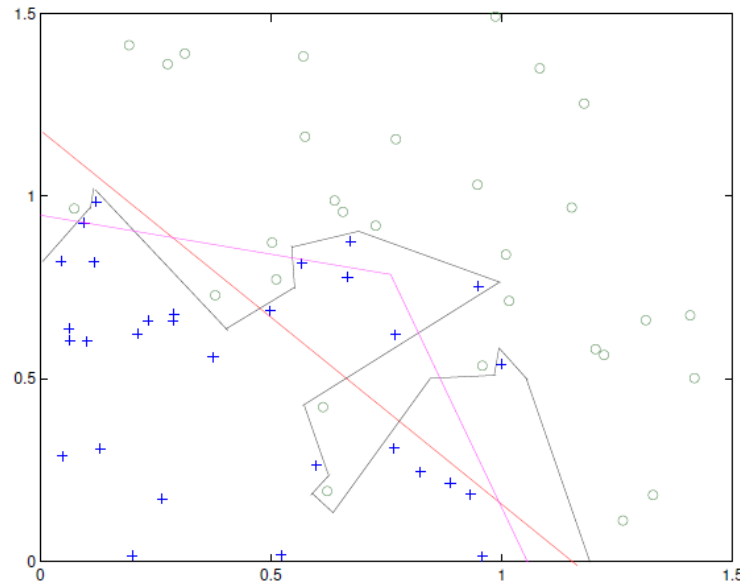
◆ In general, the noise level

$$\begin{aligned} n(x) &= \min(\mathbb{P}[Y = 1|X = x], 1 - \mathbb{P}[Y = 1|X = x]) \\ &= (1 - \eta(x))/2 \end{aligned}$$

Assumptions about P

- ◆ Need assumptions about P
 - If $t(x)$ is totally chaotic, there is no possible generalization from finite data
- ◆ Assumptions can be
 - **Preference** (e.g., a prior distribution on possible functions)
 - **Restriction** (e.g., set of possible functions)
- ◆ Treating lack of knowledge
 - Bayesian approach: uniform distribution
 - Learning theory approach: worst-case analysis

Overfitting/Underfitting



- ◆ The data can mislead you
 - ▣ **Underfitting** model too small to fit the data
 - ▣ **Overfitting** artificially good agreement with the data
- ◆ No way to detect them from the data! Need extra validation data

Empirical Risk Minimization

- ◆ Choose a **model** \mathcal{G} (set of functions)
- ◆ Minimize the empirical risk in the model

$$\min_{g \in \mathcal{G}} R_n(g)$$

- ◆ What if the Bayes classifier is not in the model?

Approximation/Estimation

◆ Bayes risk

$$R^* = \inf_g R(g)$$

- Best risk a deterministic function can have (risk of the target function, or **Bayes classifier**)

◆ Decomposition: $R(g^*) = \inf_{g \in \mathcal{G}} R(g)$

$$R(g_n) - R^* = \underbrace{R(g^*) - R^*}_{\text{Approximation}} + \underbrace{R(g_n) - R(g^*)}_{\text{Estimation}}$$

- Only the estimation error is **random** (i.e. depends on the data)
- In statistics, this is known as **bias-variance decomposition**

Bias-Variance Decomposition

- ◆ Originally coined in regression with squared error loss

$$Y_i = f(X_i) + \epsilon, \quad \epsilon \sim \mathcal{N}(0, \sigma^2)$$

- Goal: find a function $\hat{f}(X)$ to approximate the truth $Y = f(X)$ from some training dataset
- Expected square error for an unseen X :

$$\mathbb{E}[(Y - \hat{f}(X))^2] = \text{Bias}[\hat{f}(X)]^2 + \text{Var}[\hat{f}(X)] + \sigma^2$$

- where

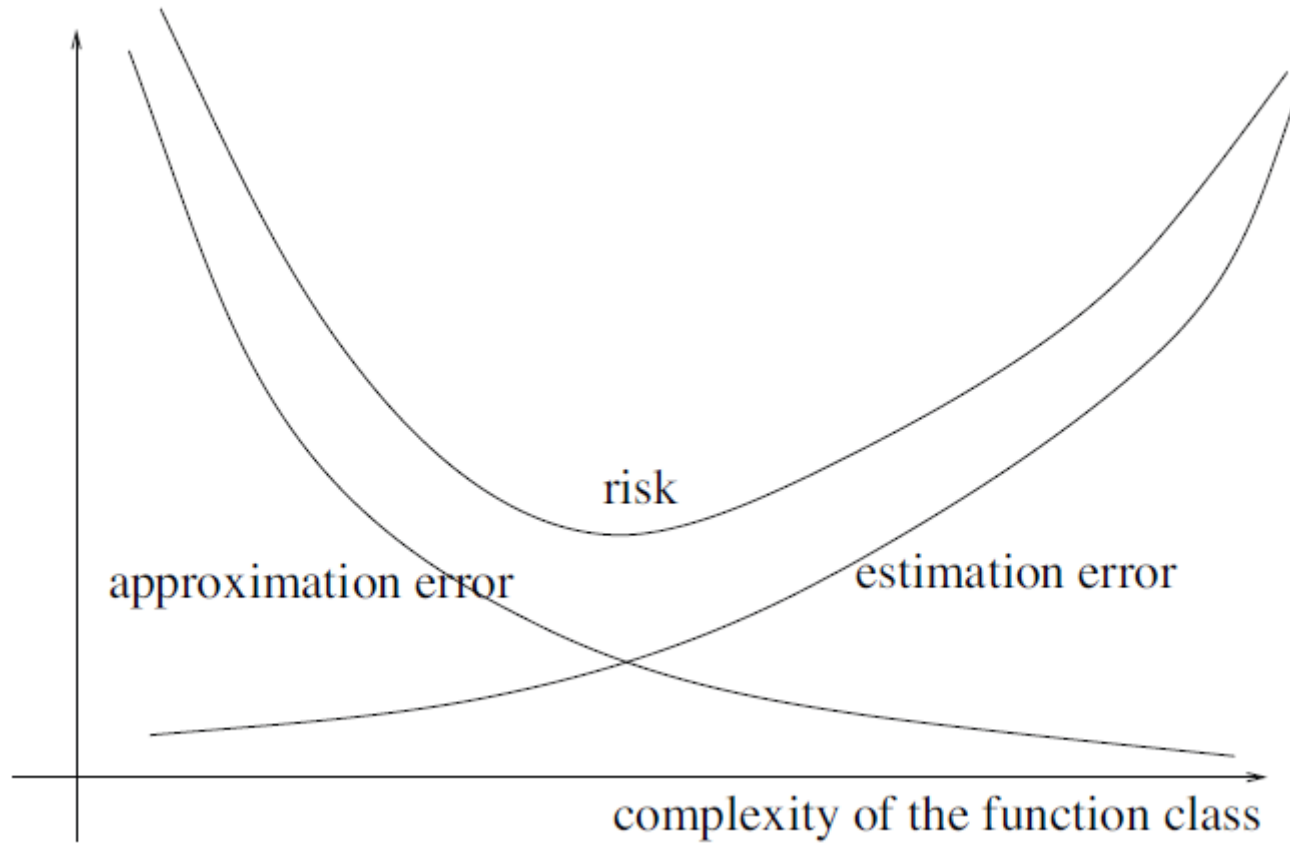
$$\text{Bias}[\hat{f}(X)] = \mathbb{E}[\hat{f}(X)] - f(X), \quad \text{Var}[\hat{f}(X)] = \mathbb{E}[(\hat{f}(X) - \mathbb{E}[\hat{f}(X)])^2]$$

- Note: expectation is taken over different choices of training set

- ◆ Now used in more general settings

Bias-Variance Decomposition

Bias-Variance Tradeoff



An example that ERM can fail

- ◆ Assume a data space $\mathcal{X} = [0, 1]$ with a uniform distribution
- ◆ Define the true label deterministically

$$Y = \begin{cases} -1 & \text{if } X < 0.5 \\ 1 & \text{if } X \geq 0.5. \end{cases}$$

- ◆ Given a set of training data, consider the classifier

$$g_n(X) = \begin{cases} Y_i & \text{if } X = X_i \text{ for some } i = 1, \dots, n \\ 1 & \text{otherwise.} \end{cases}$$

- ◆ Then, we have $R_n(g) = 0$
- ◆ But $R(g) = 1/2$
- ◆ The classifier doesn't learn anything! Overfitting!

Structural risk Minimization

- ◆ Choose a collection of models $\{\mathcal{G}_d : d = 1, 2, \dots\}$
- ◆ Minimize the empirical risk in each model
- ◆ Minimize the **penalized** empirical risk

$$\min_d \min_{g \in \mathcal{G}_d} R_n(g) + \text{pen}(d, n)$$

- $\text{pen}(d, n)$ gives preference to models where estimation error is small
- $\text{pen}(d, n)$ measures the size or capacity of the model

Regularization

- ◆ Choose a large model \mathcal{G} (possibly dense)
- ◆ Choose a regularizer $\|g\|$
- ◆ Minimize the regularized empirical risk

$$\min_{g \in \mathcal{G}} R_n(g) + \lambda \|g\|^2$$

- ◆ Choose an optimal trade-off λ (regularization parameter)
- ◆ Most methods can be thought of as regularization methods, e.g., SVMs

Bounds

- ◆ A learning algorithm
 - Takes as input the data $(X_1, Y_1), \dots, (X_n, Y_n)$
 - Produces a function g_n
- ◆ Can we estimate the risk of g_n ?
- ◆ Key points:
 - random quantity (depends on the data)
 - need probabilistic bounds

Bounds

◆ Error bounds

$$R(g_n) \leq R_n(g_n) + B$$

- Estimation from the data

◆ Relative error bounds

- Best in a class

$$R(g_n) \leq R(g^*) + B$$

- Bayes risk

$$R(g_n) \leq R^* + B$$

◆ \Rightarrow theoretical guarantees

Basic Bounds

Probability Tools

◆ Basic facts:

□ Union: $\mathbb{P}[A \text{ or } B] \leq \mathbb{P}[A] + \mathbb{P}[B]$

□ Inclusion: $\text{If } A \Rightarrow B, \text{ then } \mathbb{P}[A] \leq \mathbb{P}[B]$

□ Inversion:

$\text{If } \mathbb{P}[X \geq t] \leq F(t) \text{ then with probability at least } 1 - \delta,$

$$X \leq F^{-1}(\delta)$$

Probability Tools

◆ Basic Inequalities

□ Jensen:

for f convex, $f(\mathbb{E}[X]) \leq \mathbb{E}[f(X)]$

□ Markov:

If $X \geq 0$ then for all $t > 0$, $\mathbb{P}[X \geq t] \leq \frac{\mathbb{E}[X]}{t}$

□ Chebyshev:

for $t > 0$, $\mathbb{P}[|X - \mathbb{E}[X]| \geq t] \leq \frac{\text{Var}[X]}{t^2}$

□ Chernoff:

for all $t \in \mathbb{R}$, $\mathbb{P}[X \geq t] \leq \inf_{\lambda \geq 0} \mathbb{E}\left[e^{\lambda(X-t)}\right]$

Error Bounds

◆ Recall that we want to bound $R(g_n) = \mathbb{E} [1_{[g_n(X) \neq Y]}]$
where g_n has been constructed from $(X_1, Y_1), \dots, (X_n, Y_n)$

- Cannot be observed (P is unknown)
- Random (depends on the data)

◆ We want to bound

$$\mathbb{P} [R(g_n) - R_n(g_n) > \varepsilon]$$

Loss class

- ◆ For convenience, let $Z = (X, Y)$. Given \mathcal{G} define the loss class

$$\mathcal{F} = \{f : (x, y) \mapsto 1_{[g(x) \neq y]} : g \in \mathcal{G}\}$$

- ◆ Denote

$$Pf = \mathbb{E}[f(X, Y)] \quad P_n f = \frac{1}{n} \sum_{i=1}^n f(X_i, Y_i)$$

- ◆ Quantity of interest:

$$Pf - P_n f$$

The Law of Large Numbers

$$R(g) - R_n(g) = \mathbb{E}[f(Z)] - \frac{1}{n} \sum_{i=1}^n f(Z_i)$$

- Difference between the expectation and the empirical average of r.v. $f(Z)$

◆ Law of large numbers:

$$\mathbb{P} \left[\lim_{n \rightarrow \infty} \frac{1}{n} \sum_{i=1}^n f(Z_i) - \mathbb{E}[f(Z)] = 0 \right] = 1$$

- Can we quantify it for a finite n ?

Hoeffding's Inequality

- ◆ A quantitative version of law of large numbers
- ◆ Assumes bounded random variables

Theorem 1. *Let Z_1, \dots, Z_n be n i.i.d. random variables. If $f(Z) \in [a, b]$. Then for all $\varepsilon > 0$, we have*

$$\mathbb{P} \left[\left| \frac{1}{n} \sum_{i=1}^n f(Z_i) - \mathbb{E}[f(Z)] \right| > \varepsilon \right] \leq 2 \exp \left(-\frac{2n\varepsilon^2}{(b-a)^2} \right) .$$

Hoeffding's Inequality

◆ We can rewrite it to better understand

◆ Let $\delta = 2 \exp \left(-\frac{2n\varepsilon^2}{(b-a)^2} \right)$

◆ Then

$$\mathbb{P} \left[|P_n f - P f| > (b-a) \sqrt{\frac{\log \frac{2}{\delta}}{2n}} \right] \leq \delta$$

or [Inversion] with probability at least $1 - \delta$,

$$|P_n f - P f| \leq (b-a) \sqrt{\frac{\log \frac{2}{\delta}}{2n}}$$

Hoeffding's Inequality

- ◆ Let's apply to $f(Z) = 1_{[g(X) \neq Y]}$
- ◆ For any g and any $\delta > 0$, with probability at least $1 - \delta$

$$R(g) \leq R_n(g) + \sqrt{\frac{\log \frac{2}{\delta}}{2n}}.$$

- ◆ Notice that one has to consider a fixed function g and the probability is respect to the sampling of data
- ◆ If the function **depends on the data**, this does not apply!

Limitations

- ◆ For each fixed function $f \in \mathcal{F}$, there is a set S of samples for which

$$Pf - P_n f \leq \sqrt{\frac{\log \frac{2}{\delta}}{2n}} \quad (\mathbb{P}[S] \geq 1 - \delta)$$

- ◆ They may be different for different functions
- ◆ The function chosen by the algorithm **depends** on the sample
- ◆ For the observed sample, only some of the functions in \mathcal{F} will satisfy this inequality!

Limitations

- ◆ What we need to bound is

$$Pf_n - P_n f_n$$

- where f_n is the function chosen by the algorithm on the data

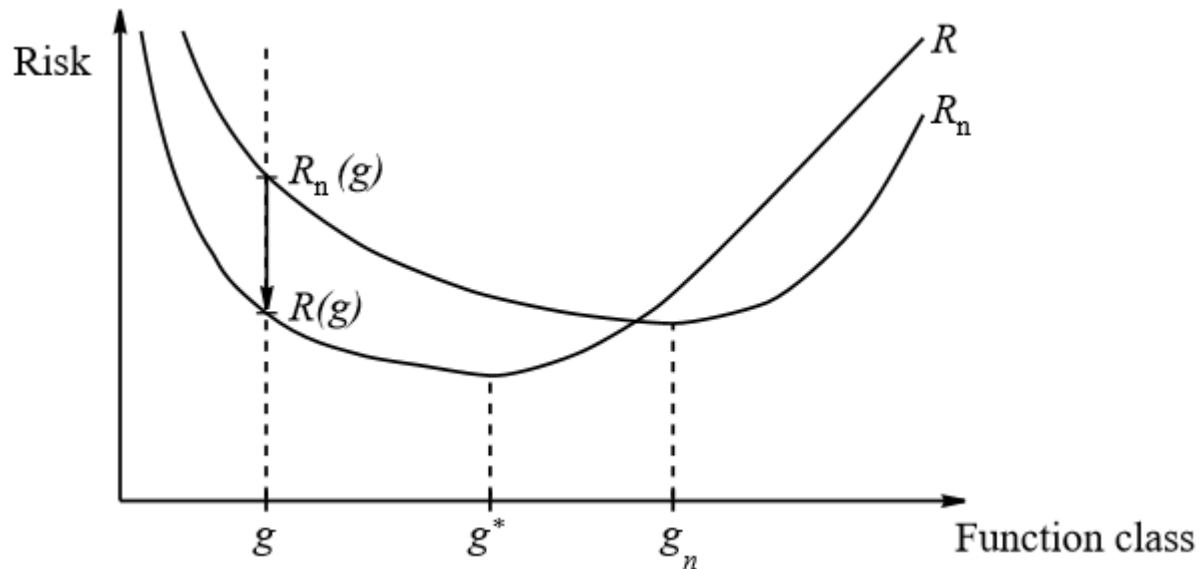
- ◆ For any fixed sample, there exists a function f such that

$$Pf - P_n f = 1$$

- E.g.: take the function which is $f(X_i) = Y_i$ on the data; and $f(X) = -Y$ elsewhere
- This does not contradict Hoeffding but shows it is not enough!

Limitations

- ◆ Hoeffding's inequality quantifies differences for *a fixed function*



Uniform Deviations

- ◆ Before seeing the data, we don't know which function the algorithm will choose
- ◆ The trick is to consider uniform deviations

$$R(f_n) - R_n(f_n) \leq \sup_{f \in \mathcal{F}} (R(f) - R_n(f))$$

- ◆ We need a bound which holds **simultaneously** for all functions in a class

Union Bound

- ◆ Consider two functions f_1, f_2 and define

$$C_i = \{(x_1, y_1), \dots, (x_n, y_n) : Pf_i - P_nf_i > \varepsilon\}$$

- ◆ From Hoeffding's inequality, for each i :

$$\mathbb{P}[C_i] \leq \delta$$

- ◆ We want to bound the probability of being “bad” for $i=1$ or $i=2$

$$\mathbb{P}[C_1 \cup C_2] \leq \mathbb{P}[C_1] + \mathbb{P}[C_2]$$

Union Bound – finite case

◆ In general, for the finite case

$$\mathbb{P}[C_1 \cup \dots \cup C_N] \leq \sum_{i=1}^N \mathbb{P}[C_i]$$

◆ We have

$$\begin{aligned} \mathbb{P}[\exists f \in \{f_1, \dots, f_N\} : Pf - P_n f > \varepsilon] \\ &\leq \sum_{i=1}^N \mathbb{P}[Pf_i - P_n f_i > \varepsilon] \\ &\leq N \exp(-2n\varepsilon^2) \end{aligned}$$

Union Bound – finite case

- ◆ We obtain, for $\mathcal{G} = \{g_1, \dots, g_N\}$, for any $\delta > 0$ with probability at least $1 - \delta$

$$\forall g \in \mathcal{G}, \quad R(g) \leq R_n(g) + \sqrt{\frac{\log N + \log \frac{1}{\delta}}{2n}}$$

- This is a **generalization** bound!

Estimation Error

◆ Let (g^* best in a class)

$$g^* = \arg \min_{g \in \mathcal{G}} R(g)$$

◆ If g_n minimizes the empirical risk in G , we have

$$R_n(g^*) - R_n(g_n) \geq 0$$

◆ Thus

$$\begin{aligned} R(g_n) &= R(g_n) - R(g^*) + R(g^*) \\ &\leq R_n(g^*) - R_n(g_n) + R(g_n) - R(g^*) + R(g^*) \\ &\leq 2 \sup_{g \in \mathcal{G}} |R(g) - R_n(g)| + R(g^*) \end{aligned}$$

◆ We obtain with probability at least $1 - \delta$

$$R(g_n) \leq R(g^*) + 2 \sqrt{\frac{\log N + \log \frac{2}{\delta}}{2n}}$$

Summary

◆ Inference requires assumptions

- Data sampled i.i.d from P
- Restrict the possible functions to G
- Choose a sequence of models to have more flexibility/control

◆ Bounds are valid w.r.t. repeated sampling

- For a fixed function g , for most of the samples

$$R(g) - R_n(g) \approx 1/\sqrt{n}$$

- For most of samples if $|\mathcal{G}| = N$

$$\sup_{g \in \mathcal{G}} R(g) - R_n(g) \approx \sqrt{\log N/n}$$

Improvements

◆ We obtained

$$\sup_{g \in \mathcal{G}} R(g) - R_n(g) \leq \sqrt{\frac{\log N + \log \frac{2}{\delta}}{2n}}$$

◆ Can be improved

- Hoeffding only uses boundedness, not the variance
- Union bound as bad as if independent
- Supremum is not what the algorithm chooses

Refined Union Bound

- ◆ For each $f \in \mathcal{F}$, apply Hoeffding's inequality

$$\mathbb{P} \left[Pf - P_n f > \sqrt{\frac{\log \frac{1}{\delta(f)}}{2n}} \right] \leq \delta(f)$$

- ◆ Thus, if we have a **countable set** \mathcal{F} , the union bound yields

$$\mathbb{P} \left[\exists f \in \mathcal{F} : Pf - P_n f > \sqrt{\frac{\log \frac{1}{\delta(f)}}{2n}} \right] \leq \sum_{f \in \mathcal{F}} \delta(f)$$

- ◆ Choose $\delta(f) = \delta p(f)$ with $\sum_{f \in \mathcal{F}} p(f) = 1$

- ◆ With probability at least $1 - \delta$

$$\forall f \in \mathcal{F}, Pf \leq P_n f + \sqrt{\frac{\log \frac{1}{p(f)} + \log \frac{1}{\delta}}{2n}}$$

- Can put **prior knowledge** about the algorithm into $p(f)$!

Infinite Case: VC Theory

Infinite Case

◆ Measure of the size of an infinite class?

◆ Consider

$$\mathcal{F}_{z_1, \dots, z_n} = \{(f(z_1), \dots, f(z_n)) : f \in \mathcal{F}\}$$

- The size of this set is the number of possible ways in which the data (z_1, \dots, z_n) can be classified

◆ Growth function

$$S_{\mathcal{F}}(n) = \sup_{(z_1, \dots, z_n)} |\mathcal{F}_{z_1, \dots, z_n}|$$

- Note that $S_{\mathcal{F}}(n) = S_{\mathcal{G}}(n)$

Infinite Case

◆ Result (Vapnik-Chervonenkis): with probability at least $1 - \delta$

$$\forall g \in \mathcal{G}, R(g) \leq R_n(g) + 2\sqrt{2 \frac{\log S_{\mathcal{G}}(2n) + \log \frac{2}{\delta}}{n}} \quad 4$$

- Always better than N in the finite case ($S_{\mathcal{G}}(n) \leq N$)
- How to compute $S_{\mathcal{G}}(n)$ in general?
- \Rightarrow use **VC dimension**!

VC Dimension

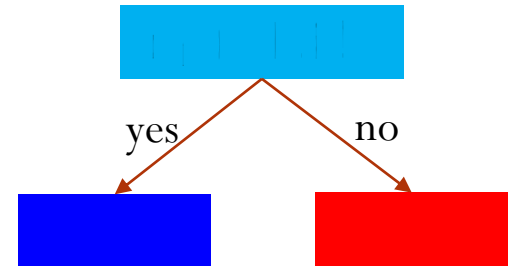
- ◆ Note that since $g \in \{-1, 1\}$, $S_{\mathcal{G}}(n) \leq 2^n$
- ◆ If $S_{\mathcal{G}}(n) = 2^n$, the class of functions can generate any classification on n points (**shattering**)
- ◆ **Definition:** The **VC-dimension** of \mathcal{G} is the largest n such that

$$S_{\mathcal{G}}(n) = 2^n$$

Example of VC Dimension

◆ Decision stumps in 2D

- 3 data points can be shattered



- How about 3 points in the same line?
 - Degenerating case (1D)!
- $VC \geq 3$

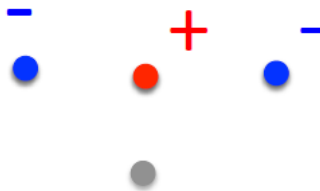
Example of VC Dimension

◆ Decision stumps in 2D

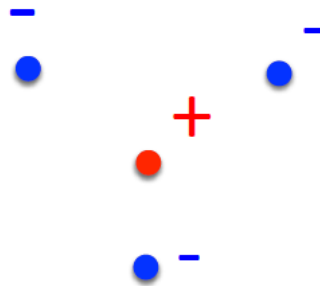
□ How about 4 data points?

- For all placements of 4 pts, there exists a labeling that can't be shattered!

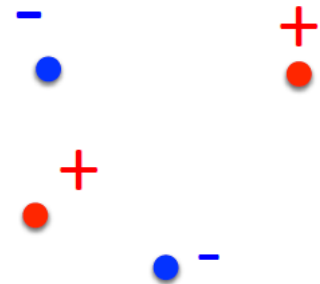
3 collinear



1 in convex hull
of other 3



quadrilateral

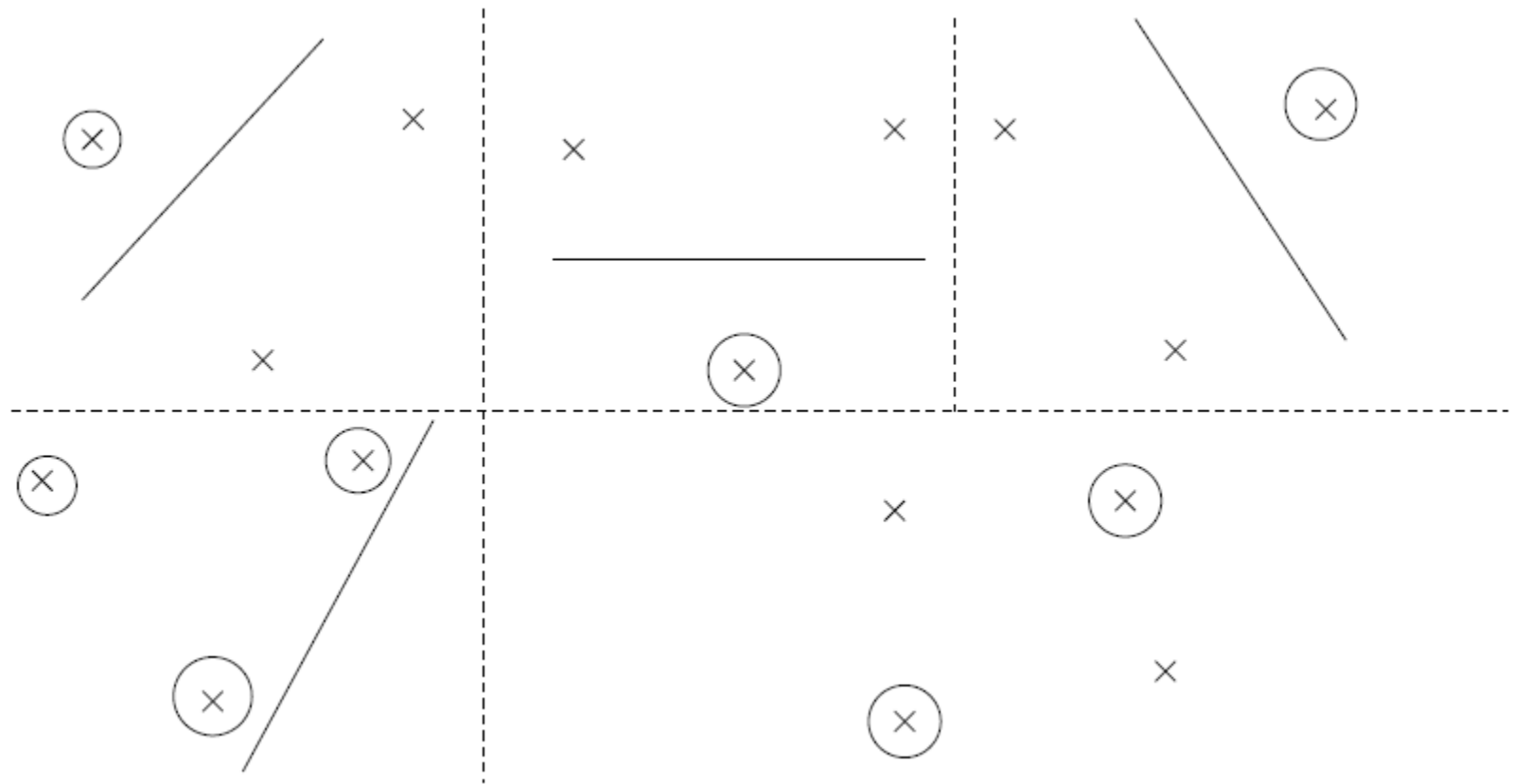


□ $VC = 3$

◆ In general, $VC = d+1$ (d-dim space)

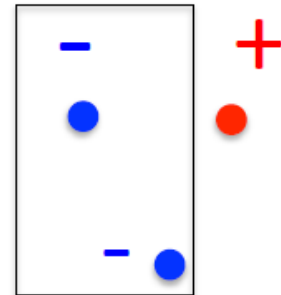
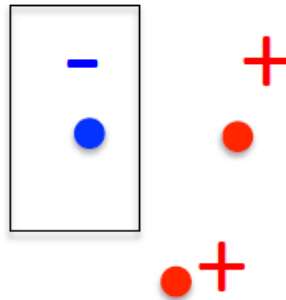
Example of VC Dimension

◆ Hyperplanes: In \mathbb{R}^d , $VC(\text{hyperplanes}) = d + 1$



Example of VC Dimension

◆ Parallel rectangles in 2D

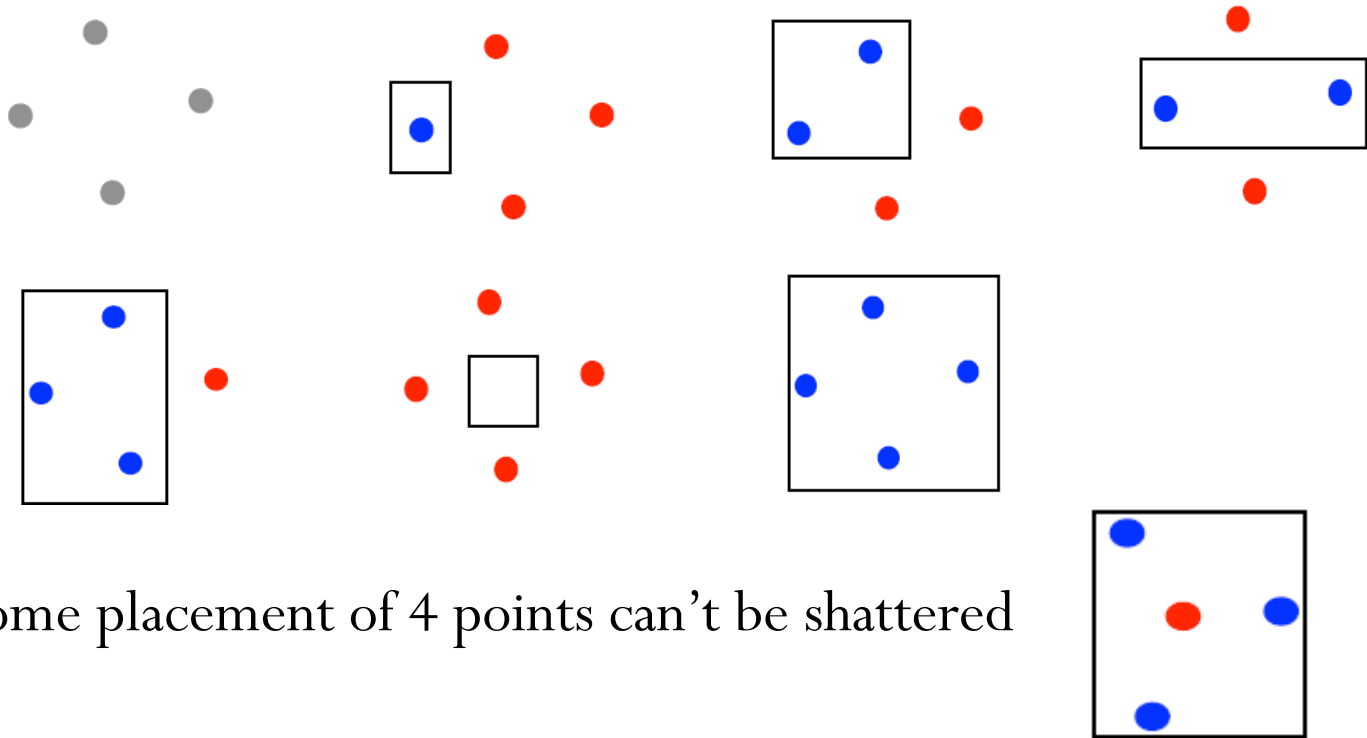


□ $VC \geq 3$

Example of VC Dimension

◆ Parallel rectangles in 2D

- How about 4 points?



- Some placement of 4 points can't be shattered

- $VC \geq 4$

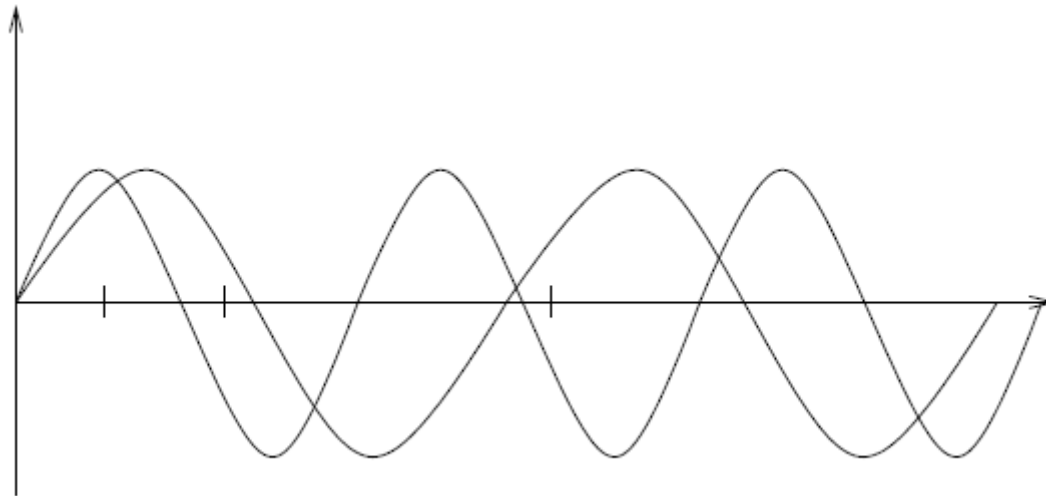
Example of VC Dimension

◆ Parallel rectangles in 2D

- How about 5 points? (homework)
- Note: if $VC = 4$, then for all placements of 5 points, there exists a labeling that can't be shattered

VC Dimension

◆ Is VC-dimension equal to number of parameters?



- One parameter $\{\text{sgn}(\sin(tx)) : t \in \mathbb{R}\}$
- Infinite VC dimension!

VC Dimension

◆ Is VC-dimension equal to number of parameters?

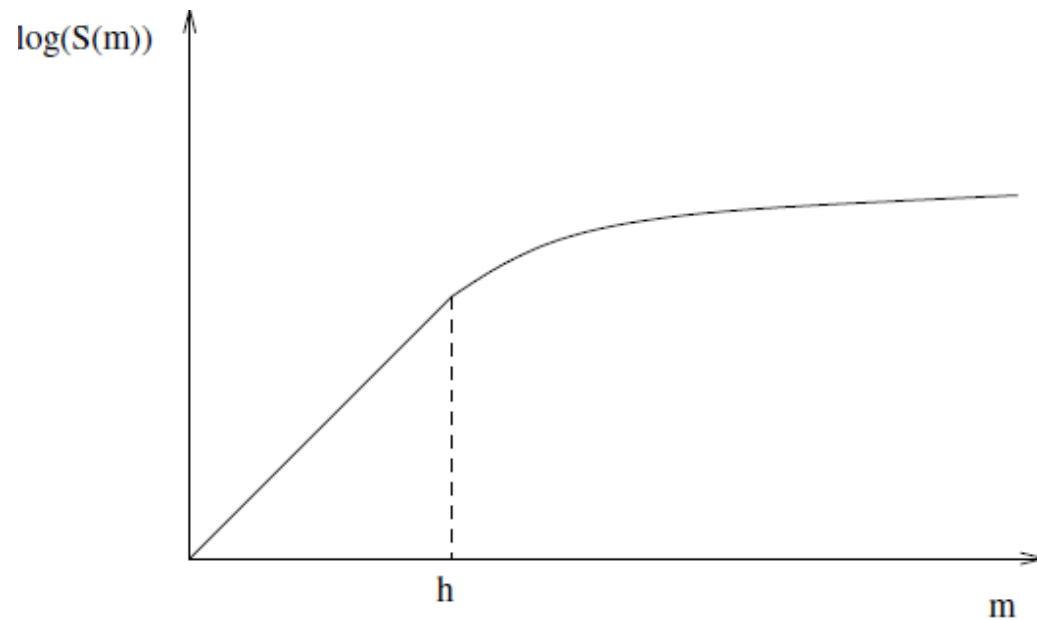
◆ 1 nearest neighbor:

□ Infinite dimension!

VC Dimension

◆ We know that $S_{\mathcal{G}}(n) = 2^n$ for $n \leq h$

◆ What happens for $n \geq h$?



Vapnik-Chervonenkis-Sauer-Shelah Lemma

- ◆ Let \mathcal{G} be a class of functions with finite VC-dimension h .
- ◆ Then for all $n \in \mathbb{N}$

$$S_{\mathcal{G}}(n) \leq \sum_{i=0}^h \binom{n}{i}$$

- ◆ and for all $n \geq h$

$$S_{\mathcal{G}}(n) \leq \left(\frac{en}{h} \right)^h$$

VC Bound

- ◆ Let \mathcal{G} be a class with VC-dimension h .
- ◆ With probability at least $1 - \delta$

$$\forall g \in \mathcal{G}, R(g) \leq R_n(g) + 2\sqrt{2 \frac{h \log \frac{2en}{h} + \log \frac{2}{\delta}}{n}}$$

- ◆ So the error is of order

$$\sqrt{\frac{h \log n}{n}}$$

Interpretation of VC Dimension

- ◆ It is a measure of **effective** dimension
 - Depends on the geometry of the class
 - Gives a natural definition of simplicity (by quantifying the potential overfitting)
 - Not related to the number of parameters
 - Finiteness guarantees **learnability** under any distribution

Symmetrization Lemma

◆ Key ingredient in VC bounds

◆ Let Z'_1, \dots, Z'_n be an independent (ghost) sample and P'_n be the corresponding empirical measure

◆ **Lemma:** for any $t > 0$, such that $nt^2 \geq 2$,

$$\mathbb{P} \left[\sup_{f \in \mathcal{F}} (P - P_n)f \geq t \right] \leq 2\mathbb{P} \left[\sup_{f \in \mathcal{F}} (P'_n - P_n)f \geq t/2 \right]$$

Proof

f_n the function achieving the supremum (depends on Z_1, \dots, Z_n)

$$\begin{aligned} \mathbf{1}_{[(P-P_n)f_n > t]} \mathbf{1}_{[(P-P'_n)f_n < t/2]} &= \mathbf{1}_{[(P-P_n)f_n > t \wedge (P-P'_n)f_n < t/2]} \\ &\leq \mathbf{1}_{[(P'_n-P_n)f_n > t/2]} \end{aligned}$$

Taking expectations with respect to the second sample gives

$$\mathbf{1}_{[(P-P_n)f_n > t]} \mathbb{P}' [(P - P'_n)f_n < t/2] \leq \mathbb{P}' [(P'_n - P_n)f_n > t/2]$$

By Chebyshev inequality,

$$\mathbb{P}' [(P - P'_n)f_n \geq t/2] \leq \frac{4\text{Var}[f_n]}{nt^2} \leq \frac{1}{nt^2}$$

Proof

◆ We have

$$\mathbf{1}_{[(P - P_n)f_n > t]} \left(1 - \frac{1}{nt^2}\right) \leq \mathbb{P}' [(P'_n - P_n)f_n > t/2]$$

◆ Take expectation with respect to first sample

Proof of VC Bound

- ◆ Symmetrization allows to replace expectation by average on ghost sample
- ◆ Function class **projected** on the double sample

$$\mathcal{F}_{Z_1, \dots, Z_n, Z'_1, \dots, Z'_n}$$

- ◆ Union bound on $\mathcal{F}_{Z_1, \dots, Z_n, Z'_1, \dots, Z'_n}$

- ◆ Variant of Hoeffding's inequality

$$\mathbb{P} [P_n f - P'_n f > t] \leq 2e^{-nt^2/2}$$

Proof of VC Bound

◆ More details

$$\begin{aligned} & \mathbb{P} \left[\sup_{f \in \mathcal{F}} (P - P_n) f \geq t \right] \\ & \leq 2 \mathbb{P} \left[\sup_{f \in \mathcal{F}} (P'_n - P_n) f \geq t/2 \right] \\ & = 2 \mathbb{P} \left[\sup_{f \in \mathcal{F}_{Z_1, \dots, Z_n, Z'_1, \dots, Z'_n}} (P'_n - P_n) f \geq t/2 \right] \\ & \leq 2 S_F(2n) \mathbb{P} \left[(P'_n - P_n) f \geq t/2 \right] \\ & \leq 4 S_F(2n) e^{-nt^2/8} \end{aligned}$$

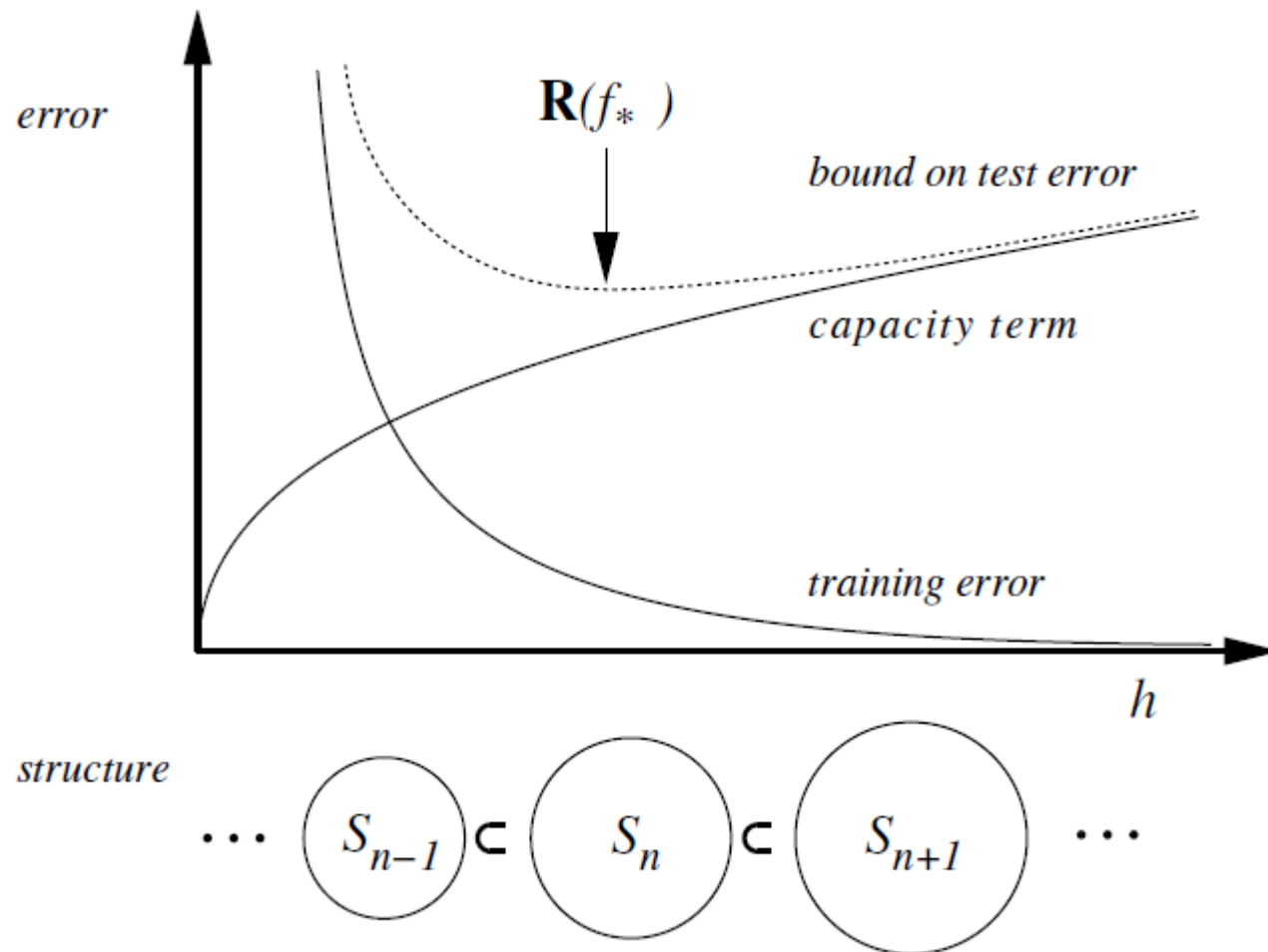
Structural Risk Minimization

◆ SRM (Vapnik, 1979): minimize the right hand side of

$$R(g) \leq R_n(g) + B(h, n)$$

- To this end, introduce a structure on \mathcal{G}

SRM: the picture



Rademacher Complexity

◆ Rademacher variables: $\sigma_1, \dots, \sigma_n$ independent r.v.s with

$$\mathbb{P}[\sigma_i = 1] = \mathbb{P}[\sigma_i = -1] = \frac{1}{2}$$

◆ Randomized empirical fitness:

$$R_n g = \frac{1}{n} \sum_{i=1}^n \sigma_i g(X_i)$$

◆ Consider all functions and define the Rademacher average:

$$\mathcal{R}(\mathcal{G}) = \mathbb{E} \left[\sup_{g \in \mathcal{G}} R_n g \right]$$

◆ Conditional Rademacher average (data fixed):

$$\mathcal{R}_n(\mathcal{G}) = \mathbb{E}_\sigma \left[\sup_{g \in \mathcal{G}} R_n g \right]$$

Error Bounds

◆ Distribution dependent

- with high probability (at least $1-\delta$)

$$\forall g \in \mathcal{G}, R(g) \leq R_n(g) + \mathcal{R}(\mathcal{G}) + \sqrt{\frac{\log(1/\delta)}{2n}}$$

◆ Data dependent

- with high probability

$$\forall g \in \mathcal{G}, R(g) \leq R_n(g) + \mathcal{R}_n(\mathcal{G}) + \sqrt{\frac{2 \log(2/\delta)}{n}}$$

- which depends solely on the data!

Computing Rademacher Average

◆ We have the rewritten form:

$$\begin{aligned} & \frac{1}{2} \mathbb{E} \left[\sup_{g \in \mathcal{G}} \frac{1}{n} \sum_{i=1}^n \sigma_i g(X_i) \right] \\ &= \frac{1}{2} + \mathbb{E} \left[\sup_{g \in \mathcal{G}} \frac{1}{n} \sum_{i=1}^n -\frac{1 - \sigma_i g(X_i)}{2} \right] \\ &= \frac{1}{2} - \mathbb{E} \left[\inf_{g \in \mathcal{G}} \frac{1}{n} \sum_{i=1}^n \frac{1 - \sigma_i g(X_i)}{2} \right] \\ &= \frac{1}{2} - \mathbb{E} \left[\inf_{g \in \mathcal{G}} R_n(g, \sigma) \right] \end{aligned}$$

- Computing $\mathcal{R}_n(\mathcal{G})$ is not harder than the empirical risk minimizer!
- If the class is very large, $\mathcal{R}_n(\mathcal{G}) = \frac{1}{2}$

Relationship with VC-dimension

- ◆ For a finite set $|\mathcal{G}| = N$

$$\mathcal{R}_n(\mathcal{G}) \leq 2\sqrt{\log N/n}$$

- ◆ For a class with VC-dimension h :

$$\mathcal{R}(\mathcal{G}) \leq 2\sqrt{\frac{h \log \frac{en}{h}}{n}}$$

- ◆ Recovers the VC bound with a concentration proof!
- ◆ One can improve the bound by a chaining technique (remove the $\log n$ factor!)

$$\mathcal{R}(\mathcal{G}) \leq C\sqrt{\frac{h}{n}}$$

Randomized Classifiers

- ◆ Given \mathcal{G} a class of functions
- ◆ **Deterministic**: picks a function g_n and always use it to predict
- ◆ **Randomized**:
 - Construct a distribution ρ_n over \mathcal{G}
 - For each instance to classify, pick $g \sim \rho_n$
- ◆ Error is averaged over



Union Bound

- ◆ Let π be a (fixed) distribution over \mathcal{G}
- ◆ Recall the refined union bound

$$\forall g \in \mathcal{G}, R(g) - R_n(g) \leq \sqrt{\frac{\log \frac{1}{\pi(g)} + \log \frac{1}{\delta}}{2n}}$$

- ◆ Take expectation with respect to ρ_n

$$\forall g \in \mathcal{G}, R(\rho_n) - R_n(\rho_n) \leq \mathbb{E}_{\rho_n} \left[\sqrt{\frac{\log \frac{1}{\pi(g)} + \log \frac{1}{\delta}}{2n}} \right]$$

Union Bound

◆ We have

$$\begin{aligned}\forall g \in \mathcal{G}, \quad R(\rho_n) - R_n(\rho_n) &\leq \mathbb{E}_{\rho_n} \left[\sqrt{\frac{\log \frac{1}{\pi(g)} + \log \frac{1}{\delta}}{2n}} \right] \\ &\leq \sqrt{\frac{-\mathbb{E}_{\rho_n} [\log \pi(g)] + \log \frac{1}{\delta}}{2n}} \\ &= \sqrt{\frac{KL(\rho_n, \pi) + H(\rho_n) + \log \frac{1}{\delta}}{2n}}\end{aligned}$$

PAC-Bayesian Refinement

- ◆ It is possible to improve the previous bound
- ◆ With high probability at least $1 - \delta$

$$\forall g \in \mathcal{G}, R(\rho_n) - R_n(\rho_n) \leq \sqrt{\frac{KL(\rho_n, \pi) + \log 4n + \log \frac{1}{\delta}}{2n - 1}}$$

- ◆ Motivate development of classifiers by minimizing the bound!

PAC bound for SVMs

◆ SVMs use a linear classifier

- For d features, $VC = d+1$

$$\forall g \in \mathcal{G}, R(g) \leq R_n(g) + \sqrt{\frac{(d+1) \log \frac{2en}{d+1} + \log \frac{4}{\delta}}{8n}}$$

◆ Problems!!!

- Doesn't take margin into account
- What about kernels?
 - Polynomials: number of features grows really fast = Bad bound!

$$\frac{(p+d-1)!}{p!(d-1)!} \quad \begin{array}{l} d: \text{input features} \\ p: \text{degree of polynomials} \end{array}$$

- RBF kernels: can classify any set of points exactly!

Large Margin Bounds

- ◆ \mathcal{G} class of linear functions with all have margin at least ρ
- ◆ R : radius of the smallest sphere enclosing the data points

$$VC(\mathcal{G}) \leq \min \left\{ d, \frac{4R^2}{\rho} \right\} + 1$$

- The larger the margin of functions in class \mathcal{G} , the smaller is its VC dimension!

Large Margin Bounds

$$\forall g \in \mathcal{G}, R(g) \leq R_n^\rho(g) + C \sqrt{\frac{\frac{R^2}{\rho^2} \log n + \log \frac{1}{\delta}}{n}}$$

- ◆ $R_n^\rho(g)$ the fraction of training examples which have margin smaller than ρ
- ◆ SVMs maximize margin ρ + minimize the hinge loss
 - Optimize tradeoff training error (bias) vs. margin ρ (variance)

What you need to know

- ◆ PAC bounds on true risk in terms of empirical risk (training error) and complexity of hypothesis space
- ◆ Complexity of the classifier depends on the number of points that can be classified exactly
 - Finite case – Number of hypothesis
 - Infinite case – VC dimension
- ◆ Bias-Variance tradeoff in learning theory
- ◆ Empirical and Structural Risk Minimization
 - But often bounds too loose in practice
- ◆ Other bounds – Margin based, PAC-Bayes, ...

References

- ◆ O. Bousquet, S. Boucheron, & G. Lugosi. Introduction to Statistical Learning Theory, Lecture Notes in Artificial Intelligence, 3176:169-207, 2004.
- ◆ U. von Luxburg & B. Scholkopf. Statistical Learning Theory: Models, Concepts, and Results. Handbook of the History of Logic, 2009.